



INTERNATIONAL STANDARD

OPC unified architecture - Part 8: Data access



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OPC unified architecture - Part 8: Data access

FOREWORD

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IEC 62541-8 has been prepared by subcommittee 65E: Devices and integration in enterprise systems, of IEC technical committee 65: Industrial-process measurement, control and automation. It is an International Standard.

This fourth edition cancels and replaces the third edition published in 2020. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) addition of a "Quantity Model" which can be referenced from EngineeringUnit Properties. The model defines quantities and assigned units. In addition it provides alternative units and the conversion to them.

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- can also be used for other subtypes like Duration and Decimal.
- rules have been added when ValuePrecision has negative values.

The text of this International Standard is based on the following documents:

Draft	Report on voting
65E/1055/CDV	65E/1108/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/publications.

Throughout this document and the other parts of the IEC 62541 series, certain document conventions are used:

Italics are used to denote a defined term or definition that appears in the "Terms and definitions" clause in one of the parts of the IEC 62541 series.

Italics are also used to denote the name of a service input or output parameter or the name of a structure or element of a structure that are usually defined in tables.

The *italicized terms and names* are, with a few exceptions, written in camel-case (the practice of writing compound words or phrases in which the elements are joined without spaces, with each element's initial letter capitalized within the compound). For example, the defined term is *AddressSpace* instead of Address Space. This makes it easier to understand that there is a single definition for *AddressSpace*, not separate definitions for Address and Space.

A list of all parts in the IEC 62541 series, published under the general title *OPC Unified Architecture*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn, or
- revised.

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This part of IEC 62541 is part of the overall OPC Unified Architecture (OPC UA) standard series and defines the information model associated with Data Access (DA). It particularly includes additional *VariableTypes* and complementary descriptions of the *NodeClasses* and *Attributes* needed for Data Access, additional *Properties*, and other information and behaviour.

The complete address space model, including all *NodeClasses* and *Attributes* is specified in IEC 62541-3. The services to detect and access data are specified in IEC 62541-4.

Annex A specifies how the information received from OPC COM Data Access (DA) Servers is mapped to the Data Access model.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62541-1, *OPC Unified Architecture - Part 1: Overview and Concepts*

IEC 62541-3, *OPC Unified Architecture - Part 3: Address Space Model*

IEC 62541-4, *OPC Unified Architecture - Part 4: Services*

IEC 62541-5, *OPC Unified Architecture - Part 5: Information Model*

IEC 62541-19, *OPC Unified Architecture - Part 19: Dictionary References*

UN/CEFACT: UNECE Recommendation N°20, *Codes for Units of Measure Used in International Trade*

https://www.unece.org/cefact/codesfortrade/codes_index.html

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IEC CDD, *IEC Common Data Dictionary*, available at <https://cdd.iec.ch/>

LATEX_SIUNITX: *A comprehensive (si) units package*, available at
<https://ctan.org/pkg/siunitx>
<https://www.texdev.net/>

QUDT, *Quantities, Units, Dimensions and Data Types Ontologies*, available at
<https://QUDT.org>
<https://github.com/qudt/qudt-public-repo>

UCUM, *Unified Code for Units of Measure*, available at <https://ucum.org>

UNECE, Recommendation N° 20, *Codes for Units of Measure Used in International Trade*,
available at <https://www.unece.org/cefact/>
